MICROPROSS EMV PICC CONTACTLESS L1 DIGITAL TEST TOOL IS NOW QUALIFIED BY EMVCO

Micropross, 09/17/2018

Now National Instruments, Micropross announced today that it has received the EMVCo issued approval letter, confirming their EMVCo L1 PICC digital test tool.

This means that after a rigorous audit performed by an EMVCo appointed independent auditor, the Micropross solution has been officially declared as **compliant with EMVCo's new 3.0 test specification**.

This tool can be used by authorized EMVCo test laboratories to perform type approval sessions and propose debug services.



Stéphane Czeck, director of marketing for NFC and Wireless Charging at National Instruments, declared:

"Being able to confront their design to the latest versions of the EMVCo specifications is crucial to our customers, and we are delighted to continuously support them with them up to date test tools"

The EMVCo L1 PICC digital test specification aims to ensure that a contactless smartcard or a NFC enabled mobile device is able to correctly interact with a payment terminal from a protocol standpoint. Perturbations such as timing errors, injection of parity, or CRC errors are typically part of the test scenarios contained in this test specification.

Ni Micropross EMV L1 PICC digital test tool is part of the Contactless Test Station offering, which also includes a full coverage of the NFC Forum, ISO 10373-6, but also EMVCo L1 PICC analog, or EMVCo L1 PCD analog and digital, on the same hardware platform.

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